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# CERTIFICATE OF ANALYSIS

## IMZ 179

### REFERENCE MATERIAL OF STEEL

Analysis listed as percent by weight [% m/m]

C	0.114	Al	0.061
Si	0.375	N	0.0108
Mn	0.83	Sn	0.010
P	0.016	Co	0.016
S	0.0028	V	0.023
Cr	0.20	As	(0.007)
Ni	9.98	Nb	(0.004)
Mo	0.12	Ti	(0.001)
Cu	0.164	W	(0.023)

Values in brackets are informative

Certificate Number: IMZ179-15072024

Certificate revision history on page 4

Analysis	C	Si	Mn	P	S	Cr	Ni	Mo
1	0.107	0.350	0.779	0.0136	0.0020	0.177	9.680	0.108
2	0.107	0.354	0.796	0.0140	0.0020	0.185	9.700	0.112
3	0.108	0.358	0.830	0.0144	0.0021	0.190	9.720	0.113
4	0.109	0.370	0.830	0.0152	0.0022	0.194	9.827	0.117
5	0.110	0.379	0.833	0.0157	0.0025	0.200	9.830	0.118
6	0.110	0.380	0.834	0.0170	0.0025	0.210	9.960	0.119
7	0.110	0.381	0.836	0.0180	0.0026	0.212	10.072	0.120
8	0.110	0.383	0.847	0.0180	0.0026	0.219	10.110	0.120
9	0.111	0.387	0.850		0.0030	0.220	10.173	0.122
10	0.112	0.390	0.850		0.0030		10.270	0.129
11	0.115	0.390			0.0036		10.417	0.130
12	0.115				0.0038			
13	0.117				0.0039			
14	0.127				0.0040			
15	0.130							
16	0.132							
Average	0.114	0.375	0.829	0.0157	0.0028	0.201	9.978	0.119
SD	0.008	0.014	0.023	0.0018	0.0007	0.015	0.249	0.007
Certified	<b>0.114</b>	<b>0.375</b>	<b>0.83</b>	<b>0.016</b>	<b>0.0028</b>	<b>0.20</b>	<b>9.98</b>	<b>0.12</b>
C(95%)	0.005	0.0102	0.018	0.0016	0.0004	0.013	0.176	0.005
Analysis	Cu	Al	V	Sn	W*	N	Co	Ti*
1	0.159	0.0510	0.0200	0.0084	0.0200	0.0100	0.0115	0.0009
2	0.160	0.0530	0.0223	0.0091	0.0200	0.0102	0.0130	0.0010
3	0.160	0.0620	0.0225	0.0094	0.0210	0.0103	0.0147	0.0016
4	0.162	0.0633	0.0230	0.0110	0.0233	0.0103	0.0195	
5	0.164	0.0667	0.0233	0.0120	0.0299	0.0110	0.0201	
6	0.164	0.0713	0.0237			0.0110		
7	0.166		0.0240			0.0110		
8	0.166		0.0250			0.0115		
9	0.173		0.0250			0.0120		
10			0.0251					
Average	0.164	0.0612	0.0234	0.0100	0.0228	0.0108	0.0158	0.0012
SD	0.004	0.0079	0.0016	0.0015	0.0042	0.0007	0.0039	0.0004
Certified	<b>0.164</b>	<b>0.061</b>	<b>0.023</b>	<b>0.010</b>		<b>0.0108</b>	<b>0.016</b>	
C(95%)	0.004	0.0090	0.0012	0.0021		0.00054	0.0054	
Analysis	Pb	As*	Nb*	Sb	Al(sol)	Bi	* - informative values	
1	0.0005	0.0061	0.0034	0.0004	0.050	< 0.0001		
2	0.0014	0.0072	0.0047	0.0022				
3		0.0080	0.0047					
Average		0.0071	0.0043					
SD		0.0010	0.0008					

$C(95\%) = (t \cdot SD)/\sqrt{n-1}$  - The half-width confidence interval, calculated for the 95 % confidence level, where  $t$  is the appropriate Student's  $t$  value,  $SD$  is the interlaboratory standard deviation and  $n$  is the number of acceptable mean values. For further information regarding the confidence interval for the certified value see ISO Guide 35:1989 section 4.

**Certification Process:** Both preparation of this reference material and certification process were prepared according to requirements of ISO Guide 31, ISO Guide 34 and ISO Guide 35. This reference material is in agreement with ISO Guide 30.

**Chemical Analysis:** Chemical analyses were carried out on chips prepared by milling of the certified portion of the bars and also for some solid samples. Single values in the above table are the means obtained by individual laboratories. The following methods were used for analysis:

<b>C and S</b>	-	high frequency infra-red absorption (HFIR), AES spark;
<b>Mn</b>	-	flame AAS, AES spark, XRF, ICP-AES, photometric, titrimetric;
<b>Si</b>	-	ICP-AES, AES spark, XRF, ICP-AES, photometric, gravimetric;
<b>P</b>	-	ICP-AES, AES spark, XRF, photometric, titrimetric;
<b>Cr</b>	-	flame AAS, AES spark, XRF, ICP-AES, photometric, titrimetric;
<b>Ni</b>	-	flame AAS, AES spark, XRF, ICP-AES, photometric, gravimetric;
<b>Cu, Mo</b>	-	flame AAS, AES spark, XRF, ICP-AES, photometric;
<b>V, W</b>	-	flame AAS, AES spark, XRF, ICP-AES, photometric;
<b>Ti</b>	-	GF AAS, AES spark, ICP-AES;
<b>Al</b>	-	flame AAS, AES spark, ICP-AES, photometric;
<b>Co, Nb</b>	-	flame AAS, AES spark, XRF, ICP-AES;
<b>As, Sn</b>	-	GF AAS, AES spark, ICP-AES;
<b>N</b>	-	high temperature extraction;
<b>Al (soluble)</b>	-	ICP-AES, AES spark;
<b>Pb, Sb, Bi</b>	-	GF AAS.

**The laboratories participating in the testing of this Reference Material were:**

- Alstom Power, Elbląg, Poland
- Ferrostal, Gliwice, Poland
- Huta Lucchini, Warszawa, Poland
- Huta Małapanew, Ozimek, Poland
- Huta Trzyniec, Czech Republic
- Instytut Metalurgii Żelaza, Gliwice, Poland
- ISH Ołomuniec, Czech Republic
- Laboratorium Aplikacyjne firmy GNR, Italy
- Laboratorium Aplikacyjne firmy LECO, Praga, Czech Republic
- Laboratorium Aplikacyjne firmy Thermo-ARL, Switzerland
- Magnesy Baildon, Katowice, Poland
- Mittal Steel Poland, Oddział Dąbrowa Górnica, Poland
- Mittal Steel Poland, Oddział Kraków, Poland
- US Steel - Labortest, Koszyce, Slovakia

**Homogeneity:** The homogeneity of this reference material was evaluated with the use of statistic parameters obtained during interlaboratory tests in 1996 and found acceptable. Optical emission spectrometry with spark excitation method was used.

**Traceability:** This Reference Material was tested with the use of optical emission spectrometry with spark excitation and was found compatible to the following CRMs: CKD 180-180A, BCS 406/1 - 410/1 and IMZ 51/1-58/1.

**Production of melt:** This material was produced by Huta Baildon, Katowice. The melt was made in an open induction furnace.

**Available form:** Discs: 40 mm in diameter and 40 mm thick; chips: bottles 100g.

**Intended use:** This Reference Material is intended for use in optical emission and X-ray spectrometric methods (bulks sample) and also in classical wet methods, UV-Vis spectrometry, AAS, ICP-AES, C,S- and N- analyzers and other wet methods (chips).

**Caution:** In optical emission spectrometry with spark excitation the central part of the surface of discs (approximately 5 mm) should be avoided because of possible segregation of the material.

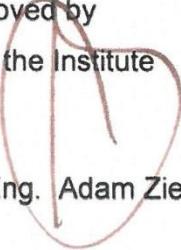
**Validity of certification:** The certification of IMZ 179 is valid indefinitely provided this Reference Material is stored in dry place and in environment free from chemical or other aggressive vapours. Periodic recertification is not required. The certification is nullified if this Reference Material is damaged, contaminated or otherwise modified.

**Chips:** if the contents of the bottle becomes changed (for example oxidized) or contaminated, the whole contents of bottle should be discarded.

**Safety:** This Reference Material and packing does not contain substances which can directly influence health.

**Storage:** This Reference Material should be stored in dry place and in environment free from chemical or other aggressive vapours.

Inquiries regarding this Reference Material should be directed to:  
rm@git.lukasiewicz.gov.pl

Approved by  
Director of the Institute  
  
Prof. Dr. Hab. Eng. Adam Zieliński

Certificate issue date: 15 July 2024

**Certificate revision history:**

15 June 2024 (editorial changes)

21 January 2021 (change of information regarding validity of certification, correction for C, Cu and S values, editorial changes);

November 2003 (Original certificate date)